## NOTES:

1. SUBSTRATE: SILICON (SI)

2. COATING

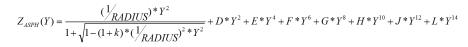
S1: R(avg) <3% @ 3 - 5μm S2: R(avg) <3% @ 3 - 5μm

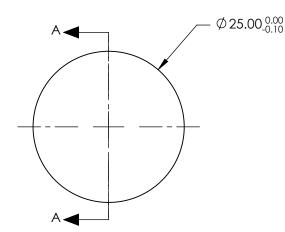
3. EDGES: DIAMOND TURNED

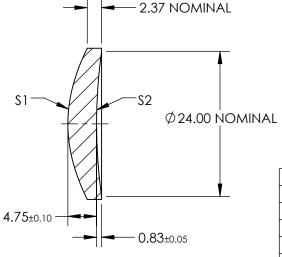
4. CENTERING, ETD: <21.8 µm

5. RoHS: COMPLIANT

6. ASPHERIC SURFACE DESCRIBED BY THE FOLLOWING EQUATION AND COEFFICIENTS SHOWN IN TABLE BELOW







SECTION A-A

COEFFICIENT TABLE COEFFIECIENT S1 -2.072484E+00 k D 0.000000E+00 Е 3.722280E-06 F 0.000000E+00 0.000000E+00 G Н 0.000000E+00 0.000000E+00 

## SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	\$1	\$2	<u></u>				L	0.0000	00E+00
SHAPE	CONVEX	CONCAVE	EFL @ 4000	)nm: 12.5		Edmund Ontion®			
RADIUS	23.373	86.361	BFL @ 4000nm: 10.7			Edmund Optics <sup>®</sup>			
SURFACE ACCURACY	<0.3µm	N/A			TITLE	25mm DIA X 12.5mm FL 3-5µm AR COATED, SI			
SURFACE QUALITY	60-40	60-40				ASPHERIC LENS		120, 51	
CLEAR APERTURE	90%	90%							CULLET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	89362			Sheet 1 Of 1

## FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING